

<b>Notice of References Cited</b>	Application/Control No. 10/633,585		Applicant(s)/Patent Under Reexamination NAKAMURA ET AL.	
	Examiner James A. Dudek		Art Unit 2871	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,330,108	12-2001	Nishikouji et al.	359/499
	B	US-6,403,223	06-2002	Albro et al.	428/421
	C	US-6,542,300	04-2003	Umemoto, Seiji	359/491
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
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**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
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**NON-PATENT DOCUMENTS**

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